## NCE N-Channel Enhancement Mode Power MOSFET

#### **Description**

The NCE4012S uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

#### **General Features**

V<sub>DS</sub> =40V,I<sub>D</sub> =12A

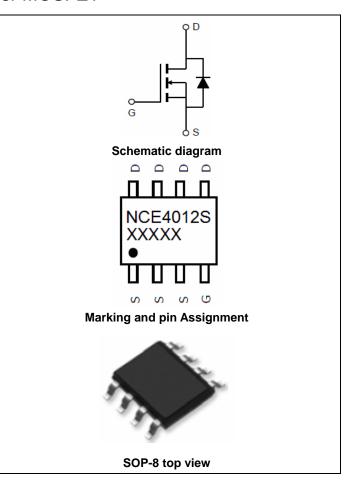
 $R_{DS(ON)}$  <12m $\Omega$  @  $V_{GS}$ =10V (Typ. 8.4 m $\Omega$ )

 $R_{DS(ON)}$  <18m $\Omega$  @  $V_{GS}$ =4.5V (Typ. 12.3 m $\Omega$ )

- High density cell design for ultra low Rdson
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E<sub>AS</sub>
- Excellent package for good heat dissipation
- Special process technology for high ESD capability

#### **Application**

- Load switching
- Hard switched and high frequency circuits
- Uninterruptible power supply



Package Marking and Ordering Information

<b>Device Marking</b>	Device	Device Package	Reel Size	Tape width	Quantity
NCE4012S	NCE4012S	SOP-8	Ø330mm	12mm	4000 units

Absolute Maximum Ratings (T<sub>A</sub>=25 ℃unless otherwise noted)

<b>9</b> ( ):					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	40	V		
Gate-Source Voltage	Vgs	±20	V		
Drain Current-Continuous	I <sub>D</sub>	12	Α		
Drain Current-Continuous(T <sub>C</sub> =100 °C)	I <sub>D</sub> (100℃)	8.5	Α		
Pulsed Drain Current	I <sub>DM</sub>	60	А		
Maximum Power Dissipation	P <sub>D</sub>	3	W		
Operating Junction and Storage Temperature Range	$T_{J}, T_{STG}$	-55 To 150	$^{\circ}$ C		

#### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	41.7	°C/W
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## Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	$V_{GS}$ =0V $I_D$ =250 $\mu$ A	40	45	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =40V,V <sub>GS</sub> =0V	-	ı	1	μA

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# NCE4012S

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)			•			•
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	1.2	1.6	2.5	V
Drain-Source On-State Resistance		V <sub>GS</sub> =10V, I <sub>D</sub> =10A	-	8.4	12	mΩ
	R <sub>DS(ON)</sub>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =8A	-	12.3	18	mΩ
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =5V,I <sub>D</sub> =10A		75	-	S
Dynamic Characteristics (Note4)			•			•
Input Capacitance	C <sub>lss</sub>	V <sub>DS</sub> =20V,V <sub>GS</sub> =0V,	-	1780	-	PF
Output Capacitance	Coss		-	209	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.0MHz	-	160	-	PF
Switching Characteristics (Note 4)			1	ı		
Turn-on Delay Time	t <sub>d(on)</sub>	$V_{DD}$ =20V, $R_L$ =2 $\Omega$ $V_{GS}$ =10V, $R_G$ =3 $\Omega$	-	6.4	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	17.2	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	29.6	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	16.8	-	nS
Total Gate Charge	Qg	V <sub>DS</sub> =20V,I <sub>D</sub> =10A,	-	38.2		nC
Gate-Source Charge	$Q_{gs}$		-	5.6		nC
Gate-Drain Charge	$Q_{gd}$	V <sub>GS</sub> =10V	-	7.4		nC
Drain-Source Diode Characteristics			•			
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =10A	-		1.2	V
Diode Forward Current (Note 2)	Is		-	-	12	А
Reverse Recovery Time	t <sub>rr</sub>	TJ = 25°C, IF = 10A	-	29	-	nS
Reverse Recovery Charge	Qrr	$di/dt = 100A/\mu s^{(Note3)}$	-	26	-	nC

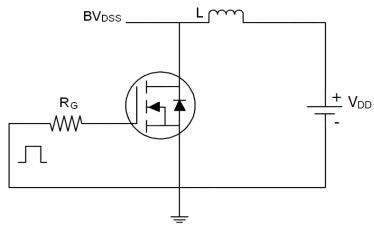
#### Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, t ≤ 10 sec.
- 3. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2%.
- 4. Guaranteed by design, not subject to production

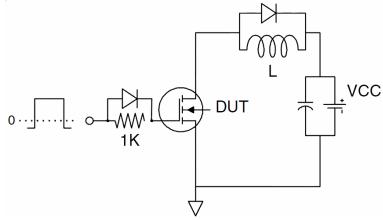


#### **Test circuit**

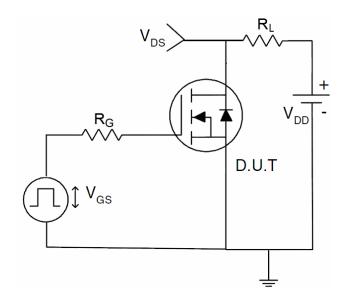
# 1) E<sub>AS</sub> Test Circuit



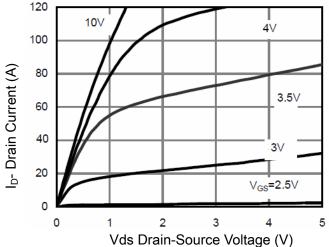
# 2) Gate Charge Test Circuit



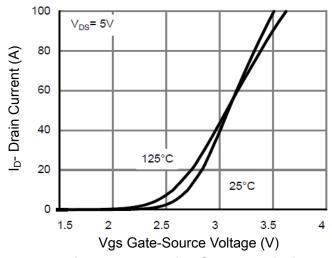
# 3) Switch Time Test Circuit







**Figure 1 Output Characteristics** 



**Figure 2 Transfer Characteristics** 

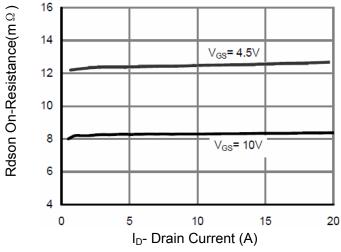


Figure 3 Rdson- Drain Current

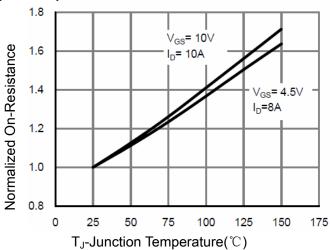


Figure 4 Rdson-JunctionTemperature

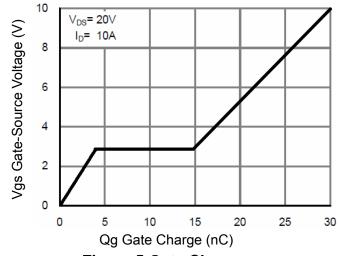


Figure 5 Gate Charge

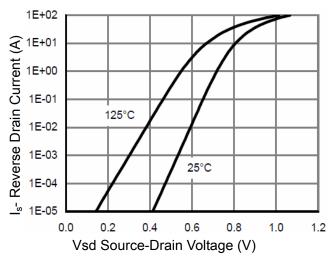
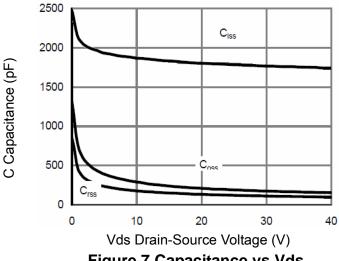


Figure 6 Source- Drain Diode Forward





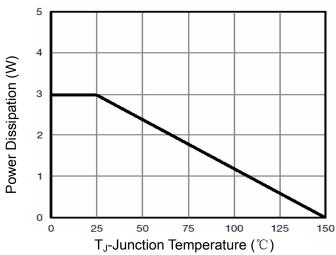
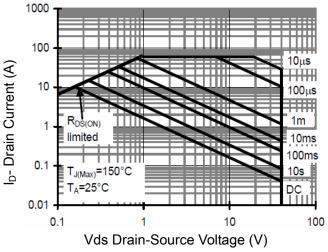


Figure 7 Capacitance vs Vds

Figure 9 Power De-rating



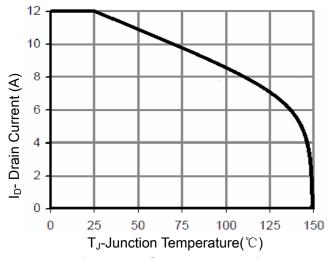
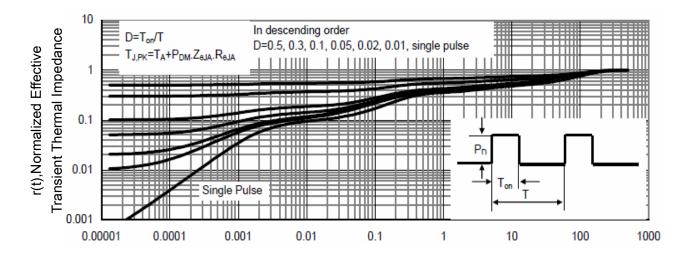


Figure 8 Safe Operation Area

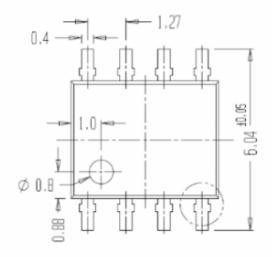
Figure 10 Current De-rating

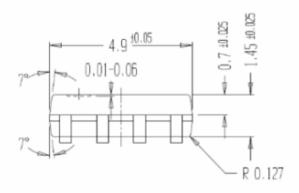


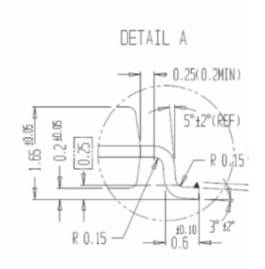
Square Wave Pluse Duration(sec)

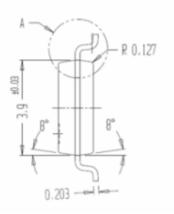
Figure 11 Normalized Maximum Transient Thermal Impedance

# **SOP-8 Package Information**













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